IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:	
PARK, Ji Yong et al.	
Application No.: TO BE ASSIGNED	Group Art Unit: TO BE ASSIGNED
Filed: October 23, 2003	Examiner:

For:

METHOD FOR MANUFACTURING POLYCRYSTALLINE SILICON THIN FILM AND THIN FILM TRANSISTOR FABRICATED USING POLYCRYSTALLINE SILICON THIN

FILM MANUFACTURED BY THE MANUFACTURING METHOD

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents PO Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure provisions of 37 CFR § 1.56, there is hereby provided certain information which the Examiner may consider material to the examination of the subject U.S. patent application. It is requested that the Examiner make this information of record if it is deemed material to the examination of the subject application.

1.		Encl	osures accompanying this Information Disclosure Statement are:
	1a. 1b.	=	Form PTO-1449. Copies of IDS citations.
	1c.	=	An English language copy of search report(s) from a counterpart foreign application or a PCT International Search Report.
	1d.		English language translation (complete or relevant portion(s)) attached to each non-English language publication.
	1e.		Explanations of Relevancy of References (ATTACHMENT 1(e), hereto) for providing a concise explanation of each non-English publication.
2.			ccordance with 37 CFR § 1.98, a concise explanation of what is presently erstood to be the relevance of each non-English language publication is
			(Check appropriate Items 2a, 2b, 2c and/or 2d)
	2a.		satisfied because all non-English language publications were cited on the enclosed "English-language version of the search report or action which indicates the degree of relevance found by the foreign office". (See MPEP 609, Minimum Requirements for an Information Disclosure Statement, Par A(3): Concise Explanation of Relevance, pp. 600-100 to 600-101, Rev. 1, Feb. 2000.)
	2b.		set forth in the application.

2c. 📙 2d. 🔲		ish language translation (complete or relevact ach non-English language publication. (e), hereto.	<i>r</i> ant			
3. No admission is made that the information cited in this Statement is, or is considered to be, material to patentability nor a representation that a search has been made (other than search report(s) from a counterpart foreign application or a PCT International Search Report, if submitted herewith). 37 CFR §§ 1.97(g) and (h).						
		Respectfully submitted,				
		STAAS & HALSEY LLP				
Dated: October 23	·	By: Mulle Deff				
1201 New York Ave Washington, D.C. Telephone: (202) 4 Facsimile: (202) 43	20005 34-1500	Michael D. Stein Registration No. 37,240				

											
					ATTORNEY DOCKET NO. 1514.1032 FIRST NAMED INVENTOR			APPLICATION NO.			
FORM PTO-1449			U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE					TO BE			
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LIST OF	REF	ERENCES (CITED BY	APPLICANT	PARK, Ji Y		_				
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					October 23, 2003			ASSIGNED			
	U.S. PATENT DOCUMENTS										
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.